


<b>Search Notes</b>  	<b>Application/Control No.</b>  10694044	<b>Applicant(s)/Patent Under Reexamination</b>  KIM ET AL.
	<b>Examiner</b>  Dawn Garrett	<b>Art Unit</b>  1794

SEARCHED			
Class	Subclass	Date	Examiner
428	32.81 690, 917 (see EAST search history printouts for all listed class/subclasses - limited by keywords)	5-14-08 and 8-12-08	DG
313	504, 506	5-14-08 and 8-12-08	DG
257	40	5-14-08 and 8-12-08	DG

SEARCH NOTES		
Search Notes	Date	Examiner
EAST search (see printout); Databases: JPO, EPO, DERWENT, USPAT, USPGPUB	5-14-08	DG
See all search notes pages in application file for full search notes history		
updated EAST search (see printout); Databases: JPO, EPO, DERWENT, USPAT, USPGPUB	8-12-08	DG
updated Inventor Name search	8-12-08	DG
updated EAST search (see attached history printout); Databases: JPO, EPO, DERWENT, USPAT, USPGPUB	1-24-2009	DG
EIC 1700 STIC search (see printout)	5-15-09	DG
updated EAST search (see printout) - Databases: JPO, EPO, DERWENT, USPAT, USPGPUB	5-22-09	DG

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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